

Search Notes

Application/Control No.

10/724,745

Examiner

Wayne Langel

Applicant(s)/Patent under Reexamination

HASEGAWA, TOSHIO

Art Unit

1754

SEARCHED

Class	Subclass	Date	Examiner
423	210	6-1-05	
423	240R	6-1-05	
427	99	6-1-05	
427	124	6-1-05	
438	680	6-1-05	
438	681	6-1-05	
438	905	6-1-05	

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner